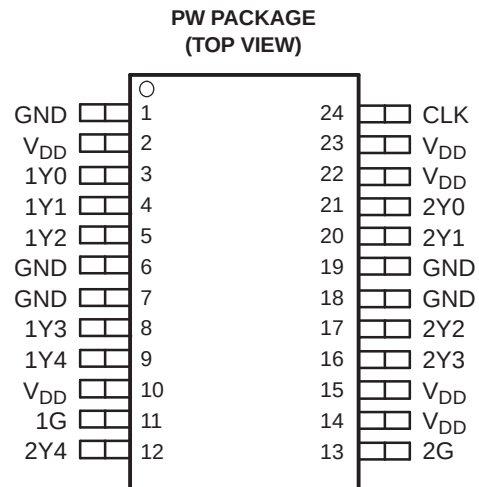


2.5-V TO 3.3-V HIGH-PERFORMANCE CLOCK BUFFER

FEATURES

- High-Performance 1:10 Clock Driver
- Pin-to-Pin Skew < 100 ps at V_{DD} 3.3 V
- V_{DD} Range = 2.3 V to 3.6 V
- Input Clock Up To 200 MHz (See [Figure 7](#))
- Operating Temperature Range -40°C to 85°C
- Output Enable Glitch Suppression
- Distributes One Clock Input to Two Banks of Five Outputs
- Packaged in 24-Pin TSSOP
- Pin-to-Pin Compatible to the CDCVF2310, Except the $R = 22\text{-}\Omega$ Series Damping Resistors at Y_n



APPLICATIONS

- General-Purpose Applications

DESCRIPTION

The CDCVF310 is a high-performance, low-skew clock buffer that operates up to 200 MHz. Two banks of five outputs each provide low-skew copies of CLK. After power up, the default state of the outputs is low regardless of the state of the control pins. For normal operation, the outputs of bank 1Y[0:4] or 2Y[0:4] can be placed in a low state when the control pins (1G or 2G, respectively) are held low and a negative clock edge is detected on the CLK input. The outputs of bank 1Y[0:4] or 2Y[0:4] can be switched into the buffer mode when the control pins (1G and 2G) are held high and a negative clock edge is detected on the CLK input. The device operates in a 2.5-V and 3.3-V environment. The built-in output enable glitch suppression ensures a synchronized output enable sequence to distribute full period clock signals.

The CDCVF310 is characterized for operation from -40°C to 85°C .

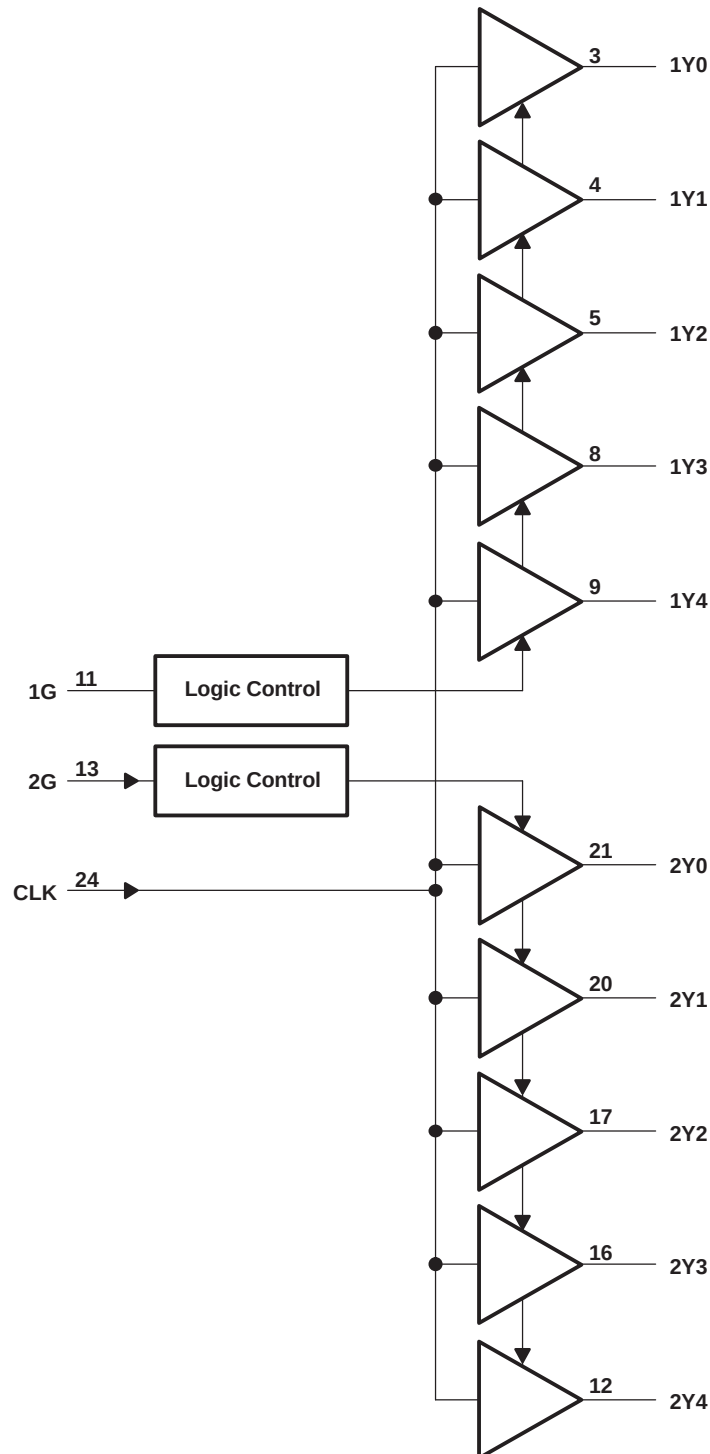


Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

FUNCTIONAL BLOCK DIAGRAM



FUNCTION TABLE

INPUT			OUTPUT	
1G	2G	CLK	1Y[0:4]	2Y[0:4]
L	L	↓	L	L
H	L	↓	CLK ⁽¹⁾	L
L	H	↓	L	CLK ⁽¹⁾
H	H	↓	CLK ⁽¹⁾	CLK ⁽¹⁾

- (1) After detecting one negative edge on the CLK input, the output follows the input CLK if the control pin is held high.

Terminal Functions

TERMINAL		I/O	DESCRIPTION
NAME	NO.		
1G	11	I	Output enable control for 1Y[0:4] outputs. This output enable is active-high, meaning the 1Y[0:4] clock outputs follow the input clock (CLK) if this pin is logic high.
2G	13	I	Output enable control for 2Y[0:4] outputs. This output enable is active-high, meaning the 2Y[0:4] clock outputs follow the input clock (CLK) if this pin is logic high.
1Y[0:4]	3, 4, 5, 8, 9	O	Buffered output clocks
2Y[0:4]	21, 20, 17, 16, 12	O	Buffered output clocks
CLK	24	I	Input reference frequency
GND	1, 6, 7, 18, 19		Ground
V _{DD}	2, 10, 14, 15, 22, 23		DC power supply, 2.3 V – 3.6 V

DETAILED DESCRIPTION

Output Enable Glitch Suppression Circuit

The purpose of the glitch suppression circuitry is to ensure the output enable sequence is synchronized with the clock input such that the output buffer is enabled or disabled on the next full period of the input clock (negative edge triggered by the input clock) (see [Figure 1](#)).

The G input must fulfill the timing requirements (t_{su} , t_h) according to the *Switching Characteristics* table for predictable operation.

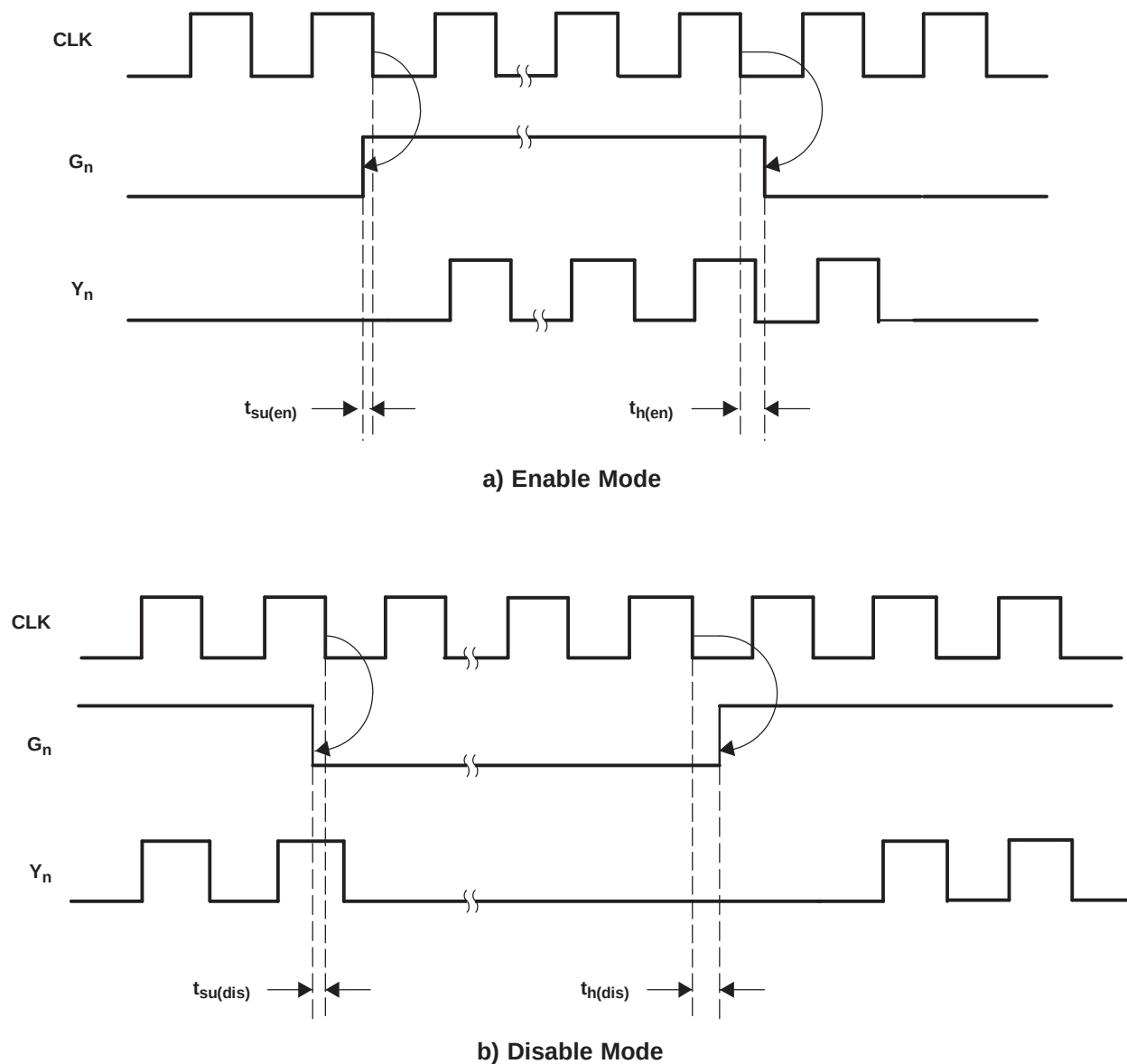


Figure 1. Enable and Disable Mode Relative to CLK↓

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted) ⁽¹⁾

Supply voltage range, V_{DD}	–0.5 V to 4.6 V
Input voltage range, V_I ⁽²⁾⁽³⁾	–0.5 V to $V_{DD} + 0.5$ V
Output voltage range, V_O ⁽²⁾⁽³⁾	–0.5 V to $V_{DD} + 0.5$ V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{DD}$)	±50 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{DD}$)	±50 mA
Continuous total output current, I_O ($V_O = 0$ to V_{DD})	±50 mA
Package thermal impedance, θ_{JA} ⁽⁴⁾ : PW package	88°C/W, high K
	120°C/W, low K
Storage temperature range T_{stg}	–65°C to 150°C

- (1) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The input and output negative voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- (3) This value is limited to 4.6 V maximum.
- (4) The package thermal impedance is calculated in accordance with JESD 51.

RECOMMENDED OPERATING CONDITIONS ⁽¹⁾

		MIN	NOM	MAX	UNIT
Supply voltage, V_{DD}		2.3	2.5		V
			3.3	3.6	
Low-level input voltage, V_{IL}	$V_{DD} = 3$ V to 3.6 V			0.8	V
	$V_{DD} = 2.3$ V to 2.7 V			0.7	
High-level input voltage, V_{IH}	$V_{DD} = 3$ V to 3.6 V	2			V
	$V_{DD} = 2.3$ V to 2.7 V	1.7			
Input voltage, V_I		0		V_{DD}	V
High-level output current, I_{OH}	$V_{DD} = 3$ V to 3.6 V			–12	mA
	$V_{DD} = 2.3$ V to 2.7 V			–6	
Low-level output current, I_{OL}	$V_{DD} = 3$ V to 3.6 V			12	mA
	$V_{DD} = 2.3$ V to 2.7 V			6	
Operating free-air temperature, T_A		–40		85	°C

- (1) Unused inputs must be held high or low to prevent them from floating.

TIMING REQUIREMENTS

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{clk}	Clock frequency	$V_{DD} = 2.3$ V to 3.6 V, See Figure 7	0		200	MHz

ELECTRICAL CHARACTERISTICSover recommended operating free-air temperature range (unless otherwise noted)⁽¹⁾

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{IK} Input voltage	V _{DD} = 3 V, I _I = –18 mA			–1.2	V
I _I Input current	V _I = 0 V or V _{DD}			±5	μA
I _{DD} ⁽²⁾ Static device current	CLK = 0 V or V _{DD} = 3.6 V, I _O = 0 mA			80	μA
C _I Input capacitance	V _{DD} = 2.3 V to 3.6 V, V _I = 0 V or V _{DD}		2.5		pF
C _O Output capacitance	V _{DD} = 2.3 V to 3.6 V, V _I = 0 V or V _{DD}		2.6		pF
C _{PD} Power dissipation ⁽³⁾	V _{DD} = 2.3 V to 3.6 V, V _I = 0 V or V _{DD}			32	pF

(1) All typical values are with respect to nominal V_{DD}.(2) For dynamic I_{DD} over Frequency see [Figure 6](#).

(3) This is the formula for the power dissipation calculation.

$$P_{\text{tot}} = P_{\text{stat}} + P_{\text{Dyn}} + P_{\text{Load}}[\text{W}]$$

$$P_{\text{stat}} = V_{\text{DD}} \times I_{\text{DD}} [\text{W}]$$

$$P_{\text{Dyn}} = C_{\text{PD}} \times V_{\text{DD}} \times V_{\text{DD}} \times f [\text{W}]$$

$$P_{\text{Load}} = C_{\text{Load}} \times V_{\text{DD}} \times V_{\text{DD}} \times f \times n [\text{W}]$$

n = Number of switching output pins

V_{DD} = 3.3 V ±0.3 V

PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{OH} High-level output voltage	V _{DD} = min to max, I _{OH} = –100 μA	V _{DD} – 0.2			V
	V _{DD} = 3 V, I _{OH} = –12 mA	2.1			
	I _{OH} = –6 mA	2.4			
V _{OL} Low-level output voltage	V _{DD} = min to max, I _{OL} = 100 μA			0.2	V
	V _{DD} = 3 V, I _{OL} = 12 mA			0.4	
	I _{OL} = 6 mA			0.3	
I _{OH} High-level output current	V _{DD} = 3 V, V _O = 1 V	–37			mA
	V _{DD} = 3.3 V, V _O = 1.65 V		–57		
	V _{DD} = 3.6 V, V _O = 3.135 V			–38	
I _{OL} Low-level output current	V _{DD} = 3 V, V _O = 1.95 V	37			mA
	V _{DD} = 3.3 V, V _O = 1.65 V		57		
	V _{DD} = 3.6 V, V _O = 0.4 V			38	

(1) All typical values are with respect to nominal V_{DD}.**V_{DD} = 2.5 V ±0.2 V**

PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{OH} High-level output voltage	V _{DD} = min to max, I _{OH} = –100 A	V _{DD} – 0.2			V
	V _{DD} = 2.3 V, I _{OH} = –6 mA	1.8			
V _{OL} Low-level output voltage	V _{DD} = min to max, I _{OL} = 100 A			0.2	V
	V _{DD} = 2.3 V, I _{OL} = 6 mA			0.4	
I _{OH} High-level output current	V _{DD} = 2.3 V, V _O = 1 V	–20			mA
	V _{DD} = 2.5 V, V _O = 1.25 V		–36		
	V _{DD} = 2.7 V, V _O = 2.375 V			–25	
I _{OL} Low-level output current	V _{DD} = 2.3 V, V _O = 1.2 V	20			mA
	V _{DD} = 2.5 V, V _O = 1.25 V		36		
	V _{DD} = 2.7 V, V _O = 0.3 V			25	

(1) All typical values are with respect to nominal V_{DD}.

JITTER CHARACTERISTICS

Characterized using CDCVF310 Performance EVM when $V_{DD}=3.3$ V. Outputs not under test are terminated to 50 Ω .

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{jitter} Additive phase jitter from input to output 1Y0	12 kHz to 5 MHz, $f_{out} = 30.72$ MHz		47		fs rms
	12 kHz to 20 MHz, $f_{out} = 125$ MHz		40		

SWITCHING CHARACTERISTICS

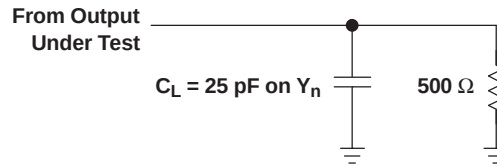
over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
$V_{DD} = 3.3$ V ± 0.3 V (see Figure 2)					
t_{PLH}	CLK to Yn $f = 0$ MHz to 200 MHz	1		2.8	ns
t_{PHL}		1		2.8	
$t_{sk(o)}$	Output skew (Ym to Yn) ⁽²⁾ (see Figure 4)		100	150	ps
$t_{sk(p)}$	Pulse skew (see Figure 5)			250	ps
$t_{sk(pp)}$	Part-to-part skew			350	ps
t_r	Rise time $V_O = 0.4$ V to 2 V	1.3		2.7	V/ns
t_f	Fall time $V_O = 2$ V to 0.4 V	1.3		2.7	V/ns
$t_{su(en)}$	Enable setup time, G_high before CLK $\downarrow$	0.1			ns
$t_{su(dis)}$	Disable setup time, G_low before CLK $\downarrow$	0.1			ns
$t_{h(en)}$	Enable hold time, G_high after CLK $\downarrow$	0.4			ns
$t_{h(dis)}$	Disable hold time, G_low after CLK $\downarrow$	0.4			ns
$V_{DD} = 2.5$ V ± 0.2 V (see Figure 2)					
t_{PLH}	CLK to Yn $f = 0$ MHz to 200 MHz	1.3		4	ns
t_{PHL}		1.3		4	
$t_{sk(o)}$	Output skew (Ym to Yn) ⁽²⁾ (see Figure 4)		150	230	ps
$t_{sk(p)}$	Pulse skew (see Figure 5)			280	ps
$t_{sk(pp)}$	Part-to-part skew			400	ps
t_r	Rise time $V_O = 0.4$ V to 1.7 V	0.5		1.6	V/ns
t_f	Fall time $V_O = 1.7$ V to 0.4 V	0.5		1.6	V/ns
$t_{su(en)}$	Enable setup time, G_high before CLK $\downarrow$	0.1			ns
$t_{su(dis)}$	Disable setup time, G_low before CLK $\downarrow$	0.1			ns
$t_{h(en)}$	Enable hold time, G_high after CLK $\downarrow$	0.4			ns
$t_{h(dis)}$	Disable hold time, G_low after CLK $\downarrow$	0.4			ns

(1) All typical values are with respect to nominal V_{DD} .

(2) The $t_{sk(o)}$ specification is only valid for equal loading of all outputs.

PARAMETER MEASUREMENT INFORMATION



- A. C_L includes probe and jig capacitance.
- B. All input pulses are supplied by generators having the following characteristics: Clock Frequency ≤ 200 MHz, $Z_O = 50 \Omega$, $t_r < 1.2$ ns, $t_f < 1.2$ ns.

Figure 2. Test Load Circuit

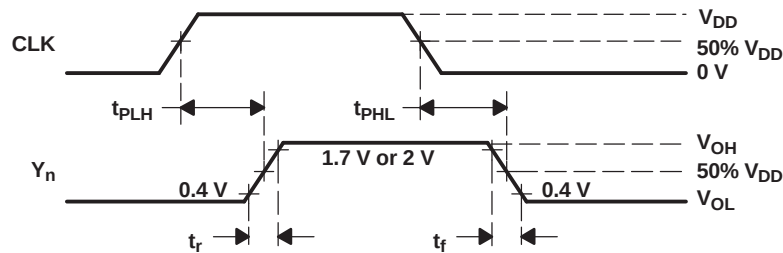


Figure 3. Voltage Waveforms Propagation Delay Times

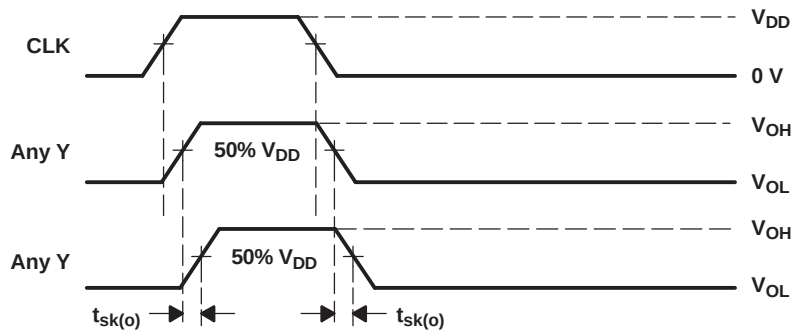
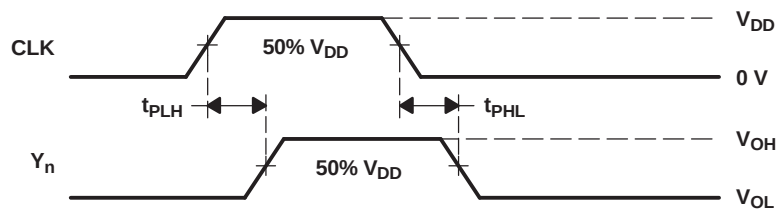


Figure 4. Output Skew



NOTE: $t_{sk(p)} = |t_{PLH} - t_{PHL}|$

Figure 5. Pulse Skew

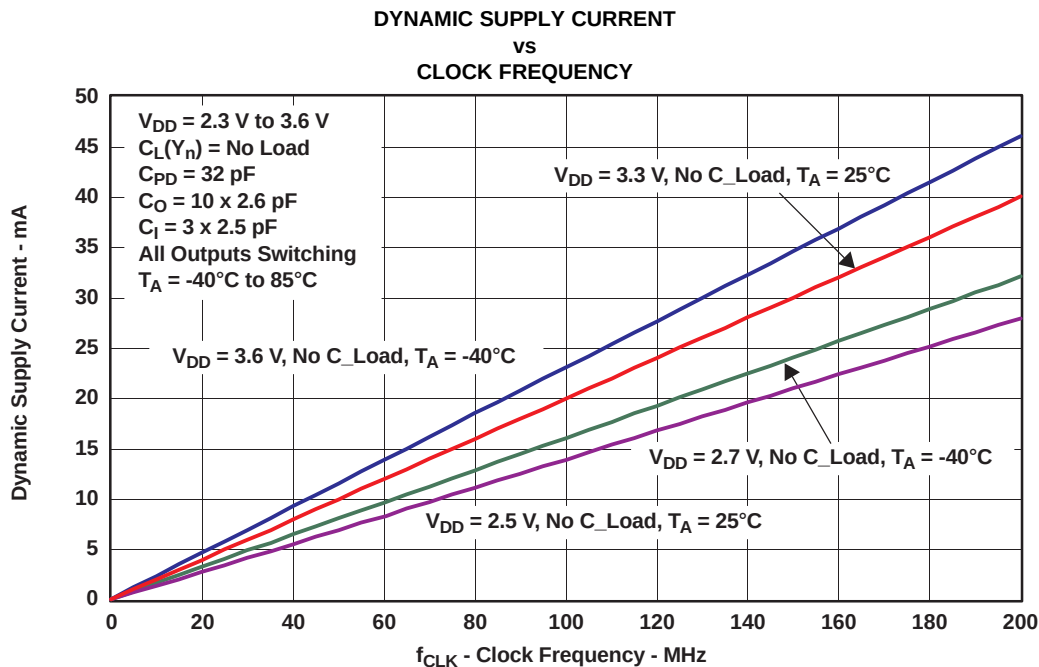


Figure 6.

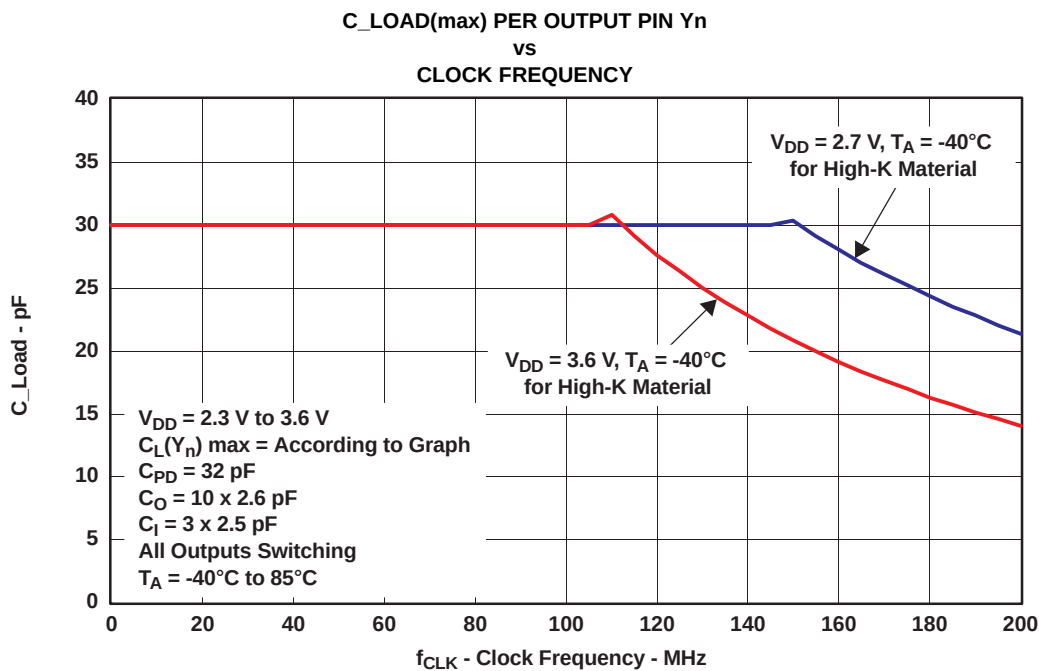


Figure 7.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CDCVF310PW	Active	Production	TSSOP (PW) 24	60 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CKV310
CDCVF310PWR	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CKV310
CDCVF310PWR1G4	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	CKV310

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

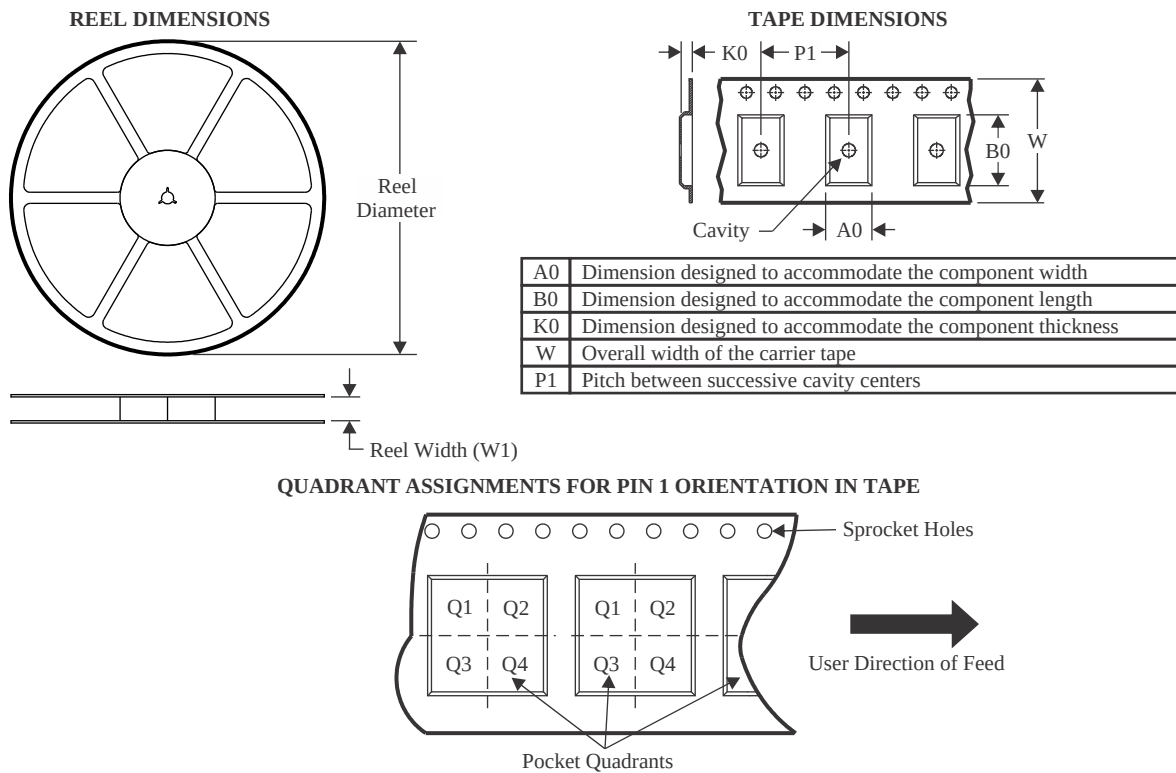
⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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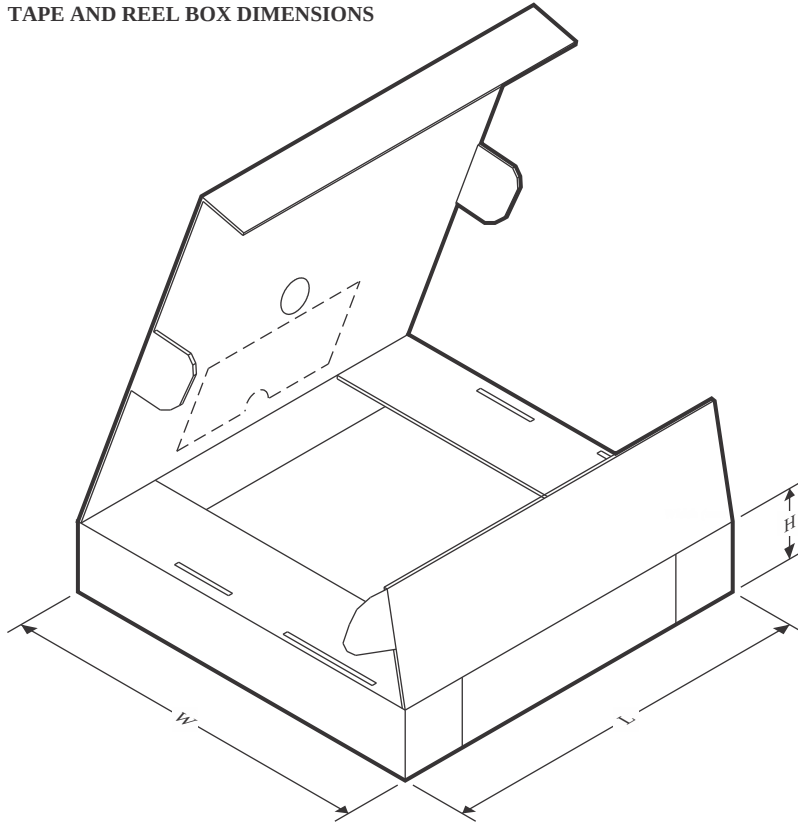
TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDCVF310PWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1
CDCVF310PWR1G4	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1

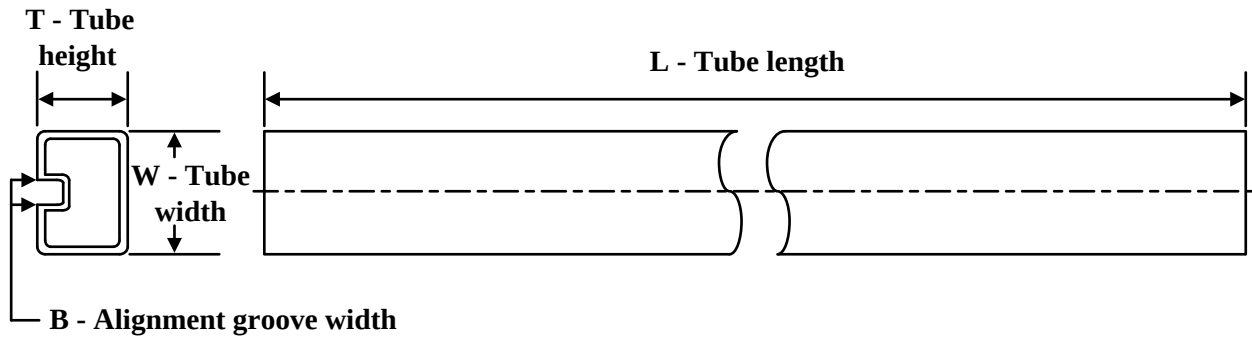
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

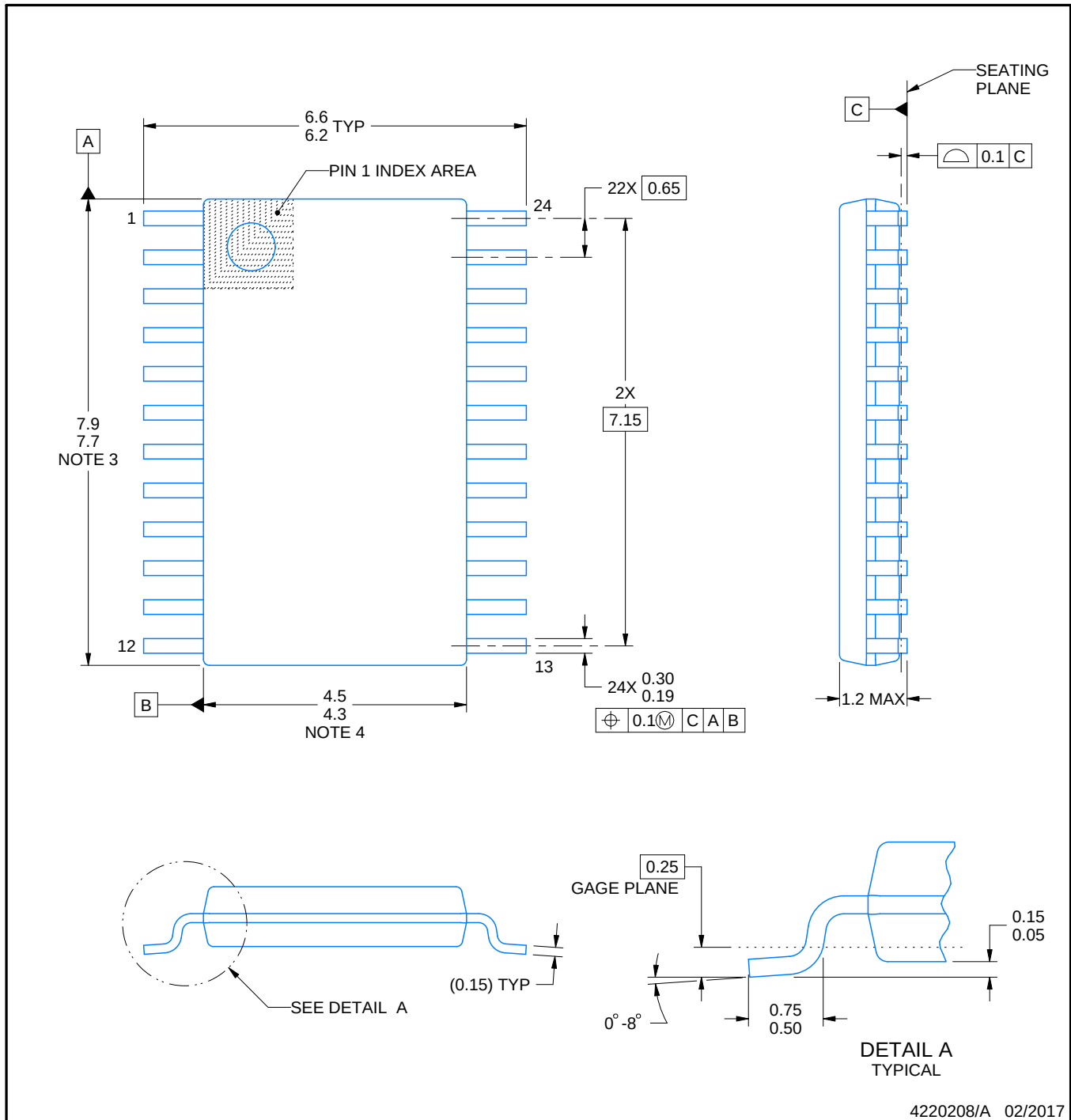
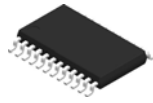
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CDCVF310PWR	TSSOP	PW	24	2000	356.0	356.0	35.0
CDCVF310PWR1G4	TSSOP	PW	24	2000	356.0	356.0	35.0

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
CDCVF310PW	PW	TSSOP	24	60	530	10.2	3600	3.5



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NOTES:

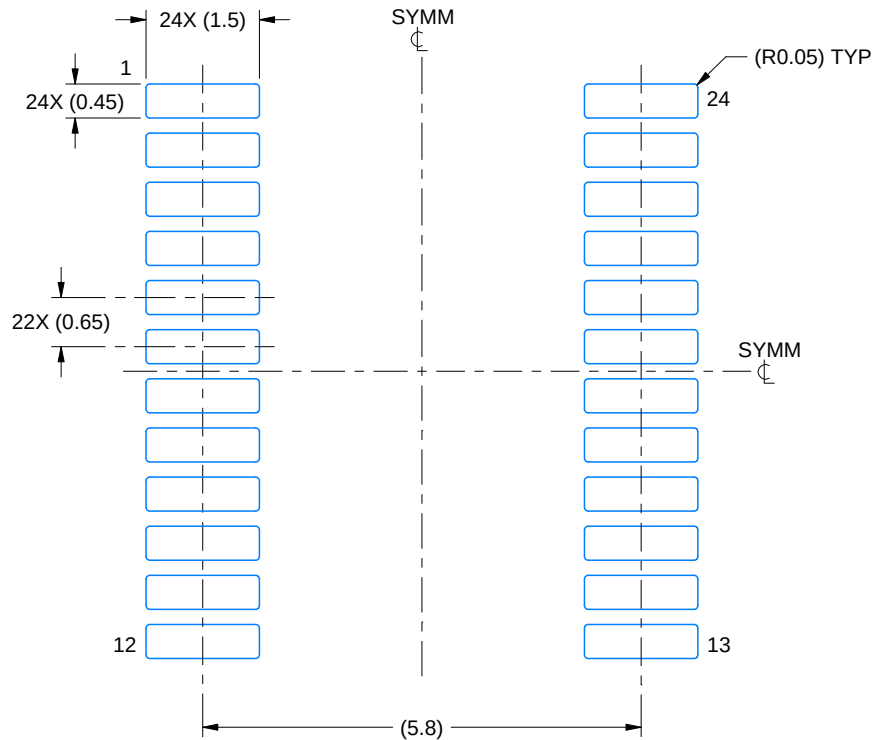
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

EXAMPLE BOARD LAYOUT

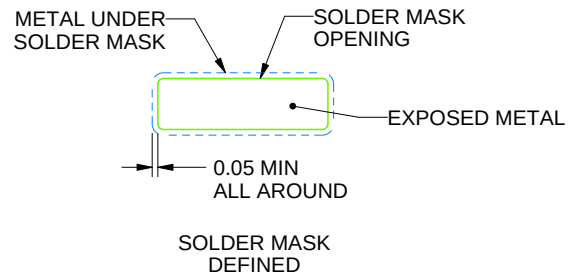
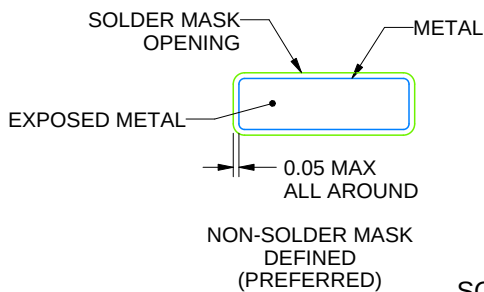
PW0024A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



SOLDER MASK DETAILS

4220208/A 02/2017

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

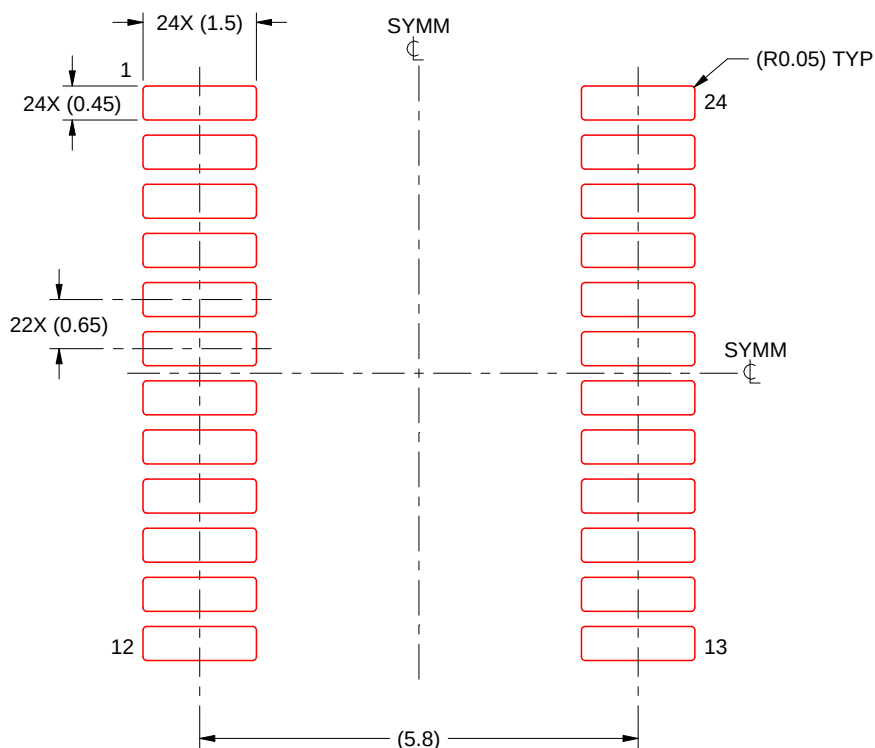
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0024A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220208/A 02/2017

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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